

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TENNEKOON ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Shin-Lin Chen	1632	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	MacKenzie et al., 2000, Experimental Cell Research, Vol. 259, p. 336-350.
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